IN THE CLAIMS:

1-25 (canceled)

- 26. (new) A high frequency plasma beam source comprising a plasma chamber for a plasma, electrical means for igniting and sustaining the plasma, an extraction grid at a high-frequency potential for extracting a plasma beam (I) from a plasma chamber as well as an outlet opening, preferably to a vacuum chamber, the extraction grid being arranged in the area of the outlet opening, wherein the plasma beam is made of a divergent shape by a specific interaction between the plasma and the extraction grid.
- 27. (new) The high-frequency plasma beam source according to claim 26, wherein the divergency of the plasma beams (I) is achieved by a non-planar shape or a large mesh width in the extraction grid.
- 28. (new) The high-frequency plasma beam source according to claim 26, wherein the achievement of a high homogeneity of the plasma current density on at least a portion of a curved, especially spherical surface that is to be irradiated, the plasma beam (I) is adapted to the shape of at least a portion of the surface area.
- 29. (new) The high-frequency plasma beam source according to claim 26, wherein the extraction grid, as seen from the plasma chamber, is of concave shape
- 30. (new) The high-frequency plasma beam source according to claim 26, wherein the extraction grid is of a non-uniform shape over at least a portion of its surface.
- 31. (new) The high-frequency plasma beam source according to claim 26, wherein at least one mask disposed outside of the plasma chamber is provided.

5

- 32. (new) The high-frequency plasma beam source according to claim 26, wherein the exit opening is covered with masks in areas.
- 33. (new) The high-frequency plasma beam source according to claim 26, wherein the extraction grid has meshes with a mesh width that is less than the thickness of the space charge zone between extraction grid and the plasma in the plasma chamber.
- 34. (new) The high-frequency plasma beam source according to claim 26, wherein the extraction grid has meshes with a mesh width that is at least as great as a thickness of the space charge zone between the extraction grid and the plasma in the plasma chamber.
- 35. (new) The high-frequency plasma beam source according to claim 34, wherein the extraction grid has meshes with a mesh width that is no more than large enough for the plasma to remain substantially within the plasma space.
- 36. (new) The high-frequency plasma beam source according to claim 26, wherein at lease one mask is provided with an electrical potential for the modulation of the plasma beam (I).
- 37. (new) The high-frequency plasma beam source according to claim 26, wherein in a coating chamber, substantially opposite the exit opening, a curved surface with substrates.
- 38. (new) The high frequency plasma bean source according to claim 37, wherein the curved surface is a dome.
- 39. (new) The high-frequency plasma beam source according to claim 26, wherein an evaporating source is provided in addition to the high-frequency plasma beam source.
- 40. (new) High-frequency plasma beam source according to claim 26, wherein the extraction grid is formed by a tungsten mesh with a wire thickness of about 0.02 3 mm.
- 41. (new) High-frequency plasma beam source according to claim 26, wherein at least one magnet is provided for locking the plasma in the area of the plasma chamber.

- 42. (new) A vacuum chamber comprising
 a housing;
 a high-frequency beam source; and
 a surface to be irradiated, wherein the high-frequency plasma beam source is configured according to claim 26.
- 43. (new) A vacuum chamber according to claim 42, wherein the surface to be irradiated is curved, preferably a dome and comprises one or more substrates.
- 44. (new) A method for irradiating a surface with a plasma beam of a high-frequency plasma beam source, consisting of a divergent plasma beam is used and the high-frequency plasma beam source is configured according to claim 25.
- 45. (new) A method according to claim 44, wherein the plasma beam has a beam characteristic with a divergence of no more than n = 16, n being an exponent of a cosine distribution function.
- 46. (new) The method of claim 45, wherein n = 4.
- 47. (new) A method according to at least claim 44, wherein the beam characteristic of the plasma beam is brought about by a controlled interaction between the plasma and an extraction grid.
- 48. (new) A method according to claim 44, wherein a controlled interaction between an extracted plasma and at least one mask disposed outside of the plasma chamber is used.
- 49. (new) A method according to claim 44, wherein for the achievement of a great homogeneity of the plasma beam density on at least a portion of a surface, the beam characteristic of the plasma beam is adapted to at least a portion of the irradiated surface.

- 50. (new) A method according to claim 44, wherein a curved surface is provided.
- 51. (new) A method according to claim 44, wherein the surface is coated by the irradiation of the surface.
- 52. (new) A method according to claim 44, wherein the surface is cleaned or modified by the irradiation of the surface.
- 53. (new) The method according to claim 50, wherein the curved surface is a dome.
- 54. (new) The high frequency plasma beam source according to claim 29, wherein a portion of the surface of the extraction grid is a section of a mantle surface of a cylindrical body.